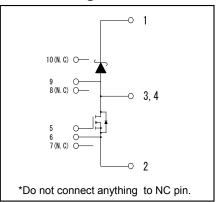
Application

- · Motor drive
- · Converter
- · Photovoltaics, wind power generation.

Features

- 1) Low surge, low switching loss.
- 2) High-speed switching possible.
- 3) Reduced temperature dependence.

●Circuit diagram



Construction

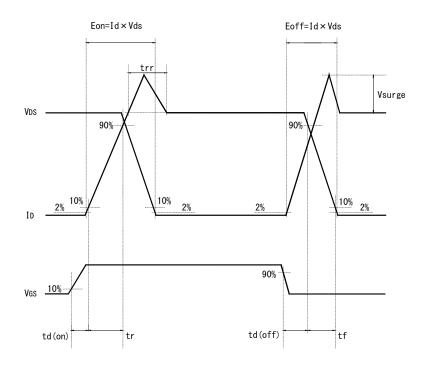
This product is a chopper module consisting of SiC-UMOSFET and SiC-SBD from ROHM.

●Absolute maximum ratings (T_j = 25°C)

Parameter	Symbol	Conditions	Limit	Unit		
Drain-source voltage	V_{DSS}	V _{DSS} G-S short				
Repetitive reverse voltage	V_{DSS}	Clamp diode	1200	V		
Gate-source voltage(+)	V	D-S short	22	1 °		
Gate-source voltage(-)	V_{GSS}	D-S SHOTE	-4	1		
Drain current *1	I _D	DC (T _c =60°C)	180			
	I _{DRM}	Pulse (T _c =60°C) 1ms *2	360			
Source current *1	I _S	DC (T _c =60°C) V _{GS} =18V	180			
	I _{SRM}	Pulse (Tc=60°C) 1ms V _{GS} =18V * ²	360	Α		
	I _{SRM}	Pulse (Tc=60°C) 10 μ s V _{GS} =0V * ²	360			
Forward curent	I _F	DC (T _c =60°C) V _{GS} =18V	180]		
(clamp diode) *1	I _{FRM}	Pulse (Tc=60°C) 1ms V _{GS} =18V * ²	360	1		
Total power disspation *3	Ptot	T _c =25°C	880	W		
Max Junction Temperature	T _{jmax}		175			
Junction temperature	T _{jop}		-40 to150	°C		
Storage temperature	T _{stg}		-40 to125			
Isolation voltage	Visol	Terminals to baseplate, f=60Hz AC 1min.	2500	Vrms		
Mounting torque		Main Terminals : M6 screw	4.5	N·m		
	_	Mounting to heat shink: M5 screw	3.5			

^(*1) Case temperature (T_c)is defined on the surface of base plate just under the chips.

Waveform for switching test



^(*2) Repetition rate should be kept within the range where temperature rise if die should not exceed $T_{j \text{ max}}$.

^(*3) T_j is less than $175^{\circ}C$

●Electrical characteristics (T_i=25°C)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
Static drain-source on-state voltage	V _{DS(on)}	I _C =180A, V _{GS} =18V	T _j =25°C	-	1.8	2.6	V
			T _j =125°C	-	2.7	-	
			T _j =150°C	-	3.1	4.0	
Drain cutoff current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V		-	-	10	μА
Forwad Voltag	V _F	I _F =180A	T _j =25°C	-	1.6	2.2	V
			T _j =125°C		2.0	-	
			T _j =150°C	-	2.2	3.3	
Reverse curent	I_{RRM}	Clamp diode		-	-	3.2	mA
Gate-source threshold voltage	$V_{GS(th)}$	V_{DS} =10V, I_{D} =50mA		2.7	-	5.6	V
Gate source leakage current	I _{GSS}	V _{GS} =22V, V _{DS} =0V		-	-	0.5	μА
Gate-source leakage current		V_{GS} = -6V, V_{DS} =0V		-0.5	-	-	
Switching characteristics	t _{d(on)}	V _{GS(on)} =18V, V _{GS(off)} =0V		-	30	-	ns
	t _r	V _{DS} =600V		-	45	-	
	t _{rr}	I _D =180A		-	20	-	
	t _{d(off)}	R_G =3.9 Ω inductive load		-	165	-	
	t _f			-	45	-	
Input capacitance	Ciss	V_{DS} =10V, V_{GS} =0V,100kHz		-	9	-	nF
Gate Registance	R_{Gint}	T _j =25°C		-	1.4	-	Ω
Stray Inductance	Ls				25	-	nH
Creepage Distance	-	Terminal to heat sink			12.5	-	mm
		Terminal to terminal			20	-	mm
Clearance Distance	-	Terminal to heat sink			10.5	-	mm
		Terminal to terminal			14.0	-	mm
Junction-to-case thermal resistance	R _{th} (j-c)	UMOS (1/2 module) *4		-	-	0.17	°C/W
		SBD (1/2 module) *4		-	-	0.14	
Case-to-heat sink Thermal resistance	R _{th} (c-f)	Case to heat sink, per 1 module,		-	0.035	-	
THEITHALIESISIANCE		Thermal grease appied *5					

^(*4) In order to prevent self turn-on, it is recommended to apply negative gate bias.

^(*5) Measurement of Tc is to be done at the point just under the chip.

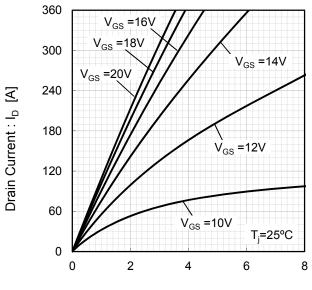
^(*6) Typical value is measured by using thermally conductive grease of λ =0.9W/(m·K).

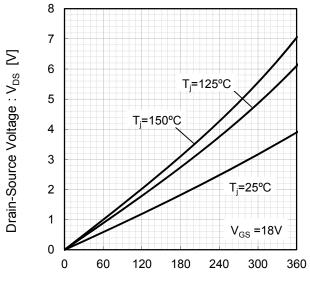
^(*7) SiC devices have lower short cuicuit withstand capability due to high current density.

Please be advised to pay careful attention to short cuicuit accident and try to adjust protection time to shutdown them as short as possible.

^(*8) If the Product is used beyond absolute maximum ratings defined in the Specifications, as its internal structure may be dameged, please replace such Product with a new one.

Fig.1 Typical Output Characteristics [T_i =25°C] Fig.2 Drain-Source Voltage vs. Drain Current





Drain-Source Voltage : V_{DS} [V]

Drain Current : I_D [A]

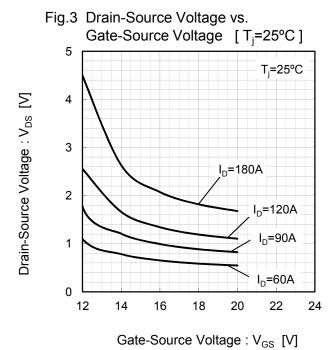
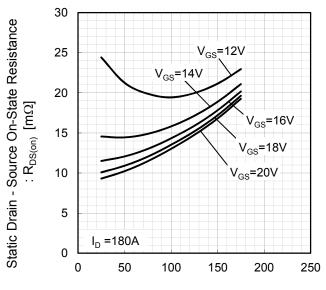


Fig.4 Static Drain - Source On-State Resistance vs. Junction Temperature



Junction Temperature : T_i [°C]

Fig.5 Forward characteristic of Diode

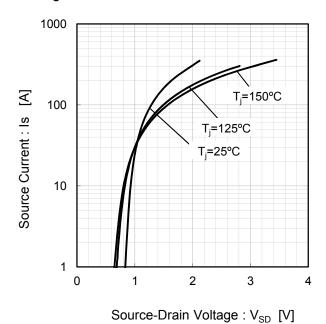
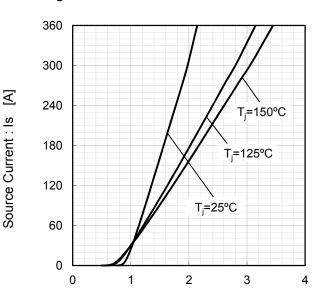


Fig.6 Forward characteristic of Diode



Source-Drain Voltage : V_{SD} [V]

Fig.7 Drain Current vs. Gate-Source Voltage

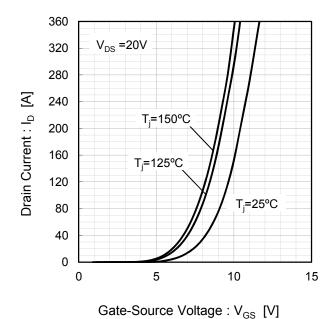
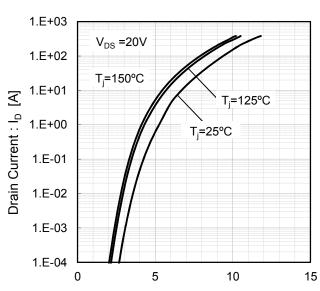


Fig.8 Drain Current vs. Gate-Source Voltage



Gate-Source Voltage : V_{GS} [V]

Fig.9 Switching Characteristics [T_i=25°C]

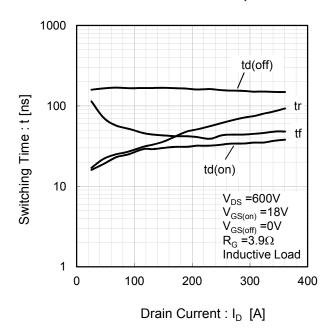


Fig.10 Switching Characteristics [T_i=125°C]

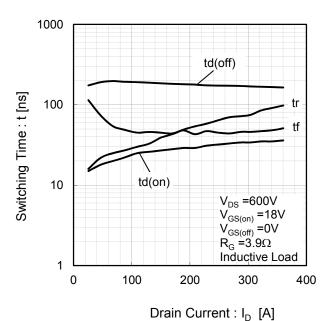


Fig.11 Switching Characteristics [T_i=150°C]

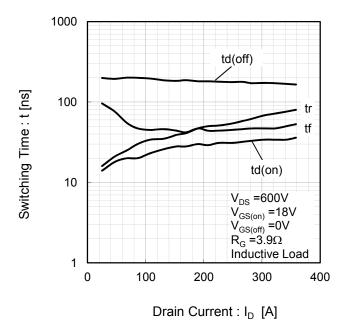
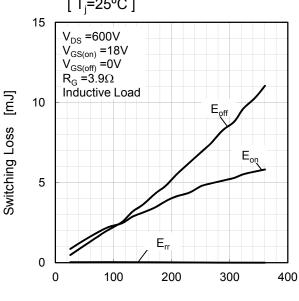


Fig.12 Switching Loss vs. Drain Current [T_i =25°C]



Drain Current : I_D [A]

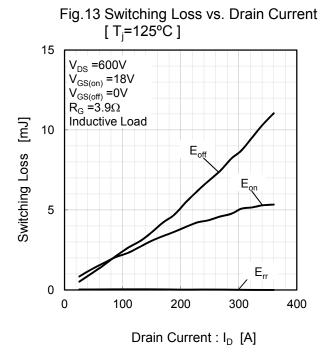
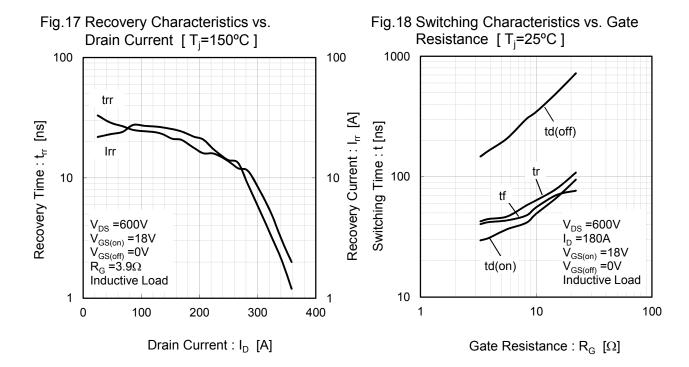
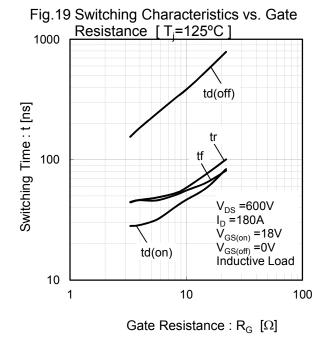


Fig.14 Switching Loss vs. Drain Current [T_i=150°C] 15 V_{DS} =600V $V_{GS(on)} = 18V$ $V_{GS(off)} = 0V$ $R_G = 3.9\Omega$ Switching Loss [mJ] Inductive Load 10 Eoff 5 E_{rr} 0 0 100 200 300 400 Drain Current : I_D [A]

Fig.15 Recovery Characteristics vs. Fig.16 Recovery Characteristics vs. Drain Current [T_i=125°C] Drain Current [T_i=25°C] 100 100 100 100 trr trr Recovery Current : Ir [A] Recovery Current: In [A] Recovery Time : t_{rr} [ns] Recovery Time: trr [ns] Irr 10 10 V_{DS} =600V V_{DS} =600V $V_{GS(on)} = 18V$ $V_{GS(off)} = 0V$ $R_G = 3.9\Omega$ $V_{GS(on)} = 18V$ $V_{GS(off)} = 0V$ $R_G = 3.9\Omega$ Inductive Load Inductive Load 1 1 0 100 200 400 0 100 200 300 400 300 Drain Current : I_D [A] Drain Current : I_D [A]





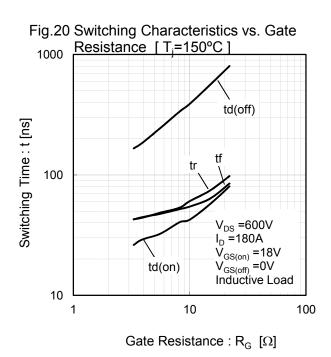


Fig.21 Switching Loss vs. Gate Resistance [T_i=25°C] 25 V_{DS} =600V I_D =180A $V_{GS(off)} = 18V$ $V_{GS(off)} = 0V$ Inductive Load 20 Switching Loss [mJ] 15 $\mathsf{E}_{\mathsf{off}}$ 10 5 Err 0 1 10 100

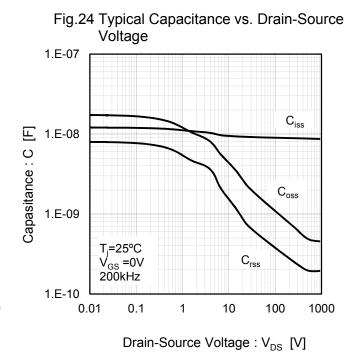
Gate Resistance : R_G [Ω]

Fig.22 Switching Loss vs. Gate Resistance $[T_j=125^{\circ}C]$ 25 $V_{DS} = 600V$ $I_D = 180A$ $V_{GS(on)} = 18V$ $V_{GS(off)} = 0V$ Inductive Load

15 E_{off} 0

1 10 100

Gate Resistance : R_G [Ω]



Switching Loss [mJ]

Fig.25 Gate Charge Characteristics

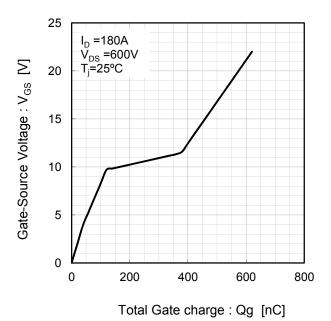


Fig.26 Normalized Transient Thermal Impedance Normalized Transient Thermal Impedance: Rth SBD **UMOS** 0.1 Single Pulse $T_c = 25$ °C Per unit base UMOS part: 0.17K/W SBD part : 0.14K/W 0.01 0.001 0.01 0.1 1 10

Time [s]

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Part Number	BSM180C12P3C202
Package	С
Unit Quantity	12
Minimum Package Quantity	12
Packing Type	Corrugated Cardboard
Constitution Materials List	inquiry
RoHS	Yes